

EMC TEST REPORT RZBG(E) 20180419001-C

Applicant

: GEOVISION INC. 9TH FL NO 246 NEIHU RD, SEC 1 NEIHU DISTRICT TAIPEI CITY, 114 TAIWAN

Manufacturer : ZHEJIANG UNIVIEW TECHNOLOGIES CO LTD

Factory : ZHEJIANG UNIVIEW TECHNOLOGIES CO LTD

Product Name :HD IP camera/IP camera

Type/Model :Appendix II

TEST RESULT :PASS

SUMMARY

The equipment complies with the requirements according to the following standards: **EN55022:2010(Class A):** information technology equipment – Radio disturbance characteristics Limits and methods of measurement.

EN 55032:2015: Electromagnetic compatibility of multimedia equipment — Emission requirements.

EN 55024:2010: Information Technology Equipment – Immunity Characteristics – Limits and methods of measurement.

EN 61000-3-2:2014: Limits for harmonic current emissions (equipment input current <=16A per phase)

EN 61000-3-3: 2013: Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current $\leq 16A$

Date of issue: May 11, 2018 Prepared by: Limin Zhong Limin Zhong 208.05.1 Reviewed by: Bing Cai Bing Cai (Reviewer) 2018.05.1



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1. GENERAL INFORMATION

1.1 Description of equipment under Test (EUT)

Product Name	:	IP camera
Description of EUT	:	This is day/nightfixed domenetwork camera. The camera provides a 100-Mbps Ethernet port. The camera can implement image capturing, image processing, and video encoding, and is applicable for IP surveillance.
Model number	:	GV-ADR4701
Sample Identification N	lo :	1
I/O Port	:	FE; Audio in/out; Alarm in/out; POE
Category of EUT	:	Class A
Rating	:	100-240V~, 50/60Hz
EUT type		☐ Table top ☐ Floor standing
Highest operating frequ	iency	: 800MHz
Sample received date	:	2017-12-25
Date of test	:	2017-12-25 ~ 2018-01-05



1.2 Description of Client

Applicants	: GEOVISION INC. 9TH FL NO 246 NEIHU RD, SEC 1 NEIHU DISTRICT TAIPEI CITY, 114 TAIWAN
Person of contact	: /
Telephone	: /
Telefax	: /
Manufacturer	: ZHEJIANG UNIVIEW TECHNOLOGIES CO LTD
Factory	: ZHEJIANG UNIVIEW TECHNOLOGIES CO LTD



1.3 Description of Test Facility

Name	Hangzhou TDT Technologies Co., Ltd.				
Address	Room 101, Building 3, No. 12, Binwen Road, Xixing Street, Binjiang district, Hangzhou, Zhejiang, China				
Telephone	+86 0571-88317620				
Telefax	+86 0571-88316350				
A2LA Certification numb	per 4037.01				
CNAS Certification numb	per CNAS L7728				
VCCI Site registration nu	number C-4683, G-832, R-4200, T-2223				
FCC Site registration nun	egistration number 494386				
IC Site registration number	er 12179A				
e project Radiated immunit	y is not in the scope list of CNAS.				
ontractor:					
e Recognition of CNAS inc	luding project Radiated immunity.				
Name	Zhejiang Testing and Inspection Institute for Mechanical and Electrical Products Quality (MEPQ Lab)				
Address	No.125, Miaohouwang Road, Binjiang District, Hangzhou, Zhejiang, China				
Telephone	+86 0571-88031780				
	Name Address Telephone Telefax A2LA Certification numb CNAS Certification numb VCCI Site registration num FCC Site registration num IC Site registration numb e project Radiated immunit ontractor: Recognition of CNAS inconstruction Name Address Telephone				

CNAS Certification number CNAS L0483 Note : The Recognition of CNAS including project Radiated immunity.



2. TEST SPECIFICATIONS

2.1 Standards

EN 55032:2015: Electromagnetic compatibility of multimedia equipment — Emission requirements.

EN 55024:2010: Information Technology Equipment – Immunity Characteristics – Limits and methods of measurement.

EN 61000-3-2:2014: Limits for harmonic current emissions (equipment input current <=16A per phase)

EN 61000-3-3: 2013: Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current <=16A

2.2 Mode of operation during the test / Test peripherals used

Configuration		EUT	
GV-ADR4701		GV-ADR4701	
Image Sensor		OV4689	
Adaptor		DC 12V,1A; POE 48V,0.25A	
	Audio IN		
	Audio		
	Out		
Ports	Video out	/	
1 0115	LAN	1	
	Alarm in		
	Alarm out		
	POE	1	

2.2.1 Configuration of the EUT

2.2.2 System Configuration during EMC Test

The Equipment under Test (EUT) was functioning correctly during all tests. The cables and auxiliary equipment detailed as below.

Cables Used during Test

Interface	Cable Type	Quantity	Length
AC Power	Unscreened	1	1.0m
Ethernet(100Base-T)	Unshielded LAN Cable	1	1.5m
Audio In	Unshielded cable	1	0.5m
Audio out	Unshielded cable	1	0.5m

Auxiliary Equipment Used during Test



0	Test report No. RZBG(E) 20180419001-C		
Notebook PC	ThinkPad T400	Lenovo	
Headphone	SHO4200	Philips	
Microphone	SHO4200	Philips	
60W Hi-Power POE Injector	PSE156G	UNIVIEW	
Adapter	ADS-65LSI-12-1	HONOR	



2.2.3 Description of Test modes

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanning tested based on the consideration of EUT operation mode 1-mode 2.

Mode 1: GV-ADR4701 with DC adapter LAN, connect to PC, open the display for IP camera DC power supply

Mode 2: GV-ADR4701 with POE adapter LAN, connect to PC, open the display for IP camera POE power supply

2.2.4 Block of Test Configurations

The PC was connected to ancillary in order to simulate normal operating conditions (with reference to the guidance given in the standard for this type of equipment).



Figure 1.Test Configuration 1 EMI/EMS at enclosure and DC mains port



2.3 Instrument list

Test Item	Test Instrument	Model	Manufacturer	Serial No.	Calibration state
	Chamber	9*6*6	Albatross projects	22603	effective
	EMI Test receiver	ESR7	R & S	101357	effective
	Signal Analyzer	FSV40	R & S	101015	effective
	PRE-AMPLIFIER (1-18GHz)	AFS44- 01001800-42- 10P-44	MITEQ	1890161	effective
Radiated	PRE-AMPLIFIER (18-40GHz)	CBL18404035	CERNEX	24496/24495	effective
Emission (RE)	Bi-conical and log- periodic Antenna	AC-220	Com-power	61068	effective
	HORN Antenna	HF906	R & S	100373	effective
	HORN Antenna	AH-840	Com-power	101076	effective
	HORN Antenna	BBHA 9120D	Schwarzbeck	01794	effective
	Coavial PE Cable	SUCOFLEX 106	Hubersuhner	NA	effective
	Coaxiai KI [*] Cable	3545- 2.92J2.92J-8M	Gore	NA	effective
	EMI Test receiver	ESR7	R & S	101357	effective
	Artificial Mains	ENV216	R & S	101276	effective
Emission	Network	ENV4200	R & S	100263	effective
(CE)	ISN	ENY81	R & S	100183	effective
	Coaxial cable	SPARE 5M	Hubersuhner	1#	effective
	50Ω Terminator	T50	/	CE0001	effective
Current Harmonic	Harmonic/flicker analyzer	PHF4010	HAEFELY	153123	effective
Voltage fluctuation and Flicker	Harmonic/flicker analyzer	PHF4010	HAEFELY	153123	effective
	Signal Generator	CWS500N	EM TEST	P1453146258	effective
	Coupling and decoupling network	CDN-M1	EM TEST	110503	effective
Conducted		CDN-M2	EM TEST	110504	effective
(CS)		CDN-M3	EM TEST	110505	effective
		CDN-T8	EM TEST	A3022009	effective
		CDN-Clamp	EM TEST	3606030868	effective
Electrical fast transient (EFT)	Signal Generator	EMS61000-4A	EVERFINE	G118209TF1 341114	effective
	EFT Clamp	EFTC-2	EVERFINE	G100306CS1 341118	effective
Electrostatic discharge (ESD)	ESD Gun	ESS-B301118	NOISEKEN	ESS1745628	effective
SUPCE	Signal Generator 1.2/50us 10kV	EMS61000-5H	EVERFINE	G134362CM 5361113	effective
SURGE	Signal Generator 10/700us 6kV	EMS61000-5D	EVERFINE	Y100370C01 321112	effective

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	Courting and	SNG-8	EVERFINE	Y118625TN1 321112	effective
	decoupling and	SGN-7	EVERFINE	Y118626CJ1 331112	effective
	network	SGN-2H	EVERFINE	G117476TM1 341113	effective
Voltage dips,short interruptions and voltage variations on A.C	Signal Generator	EMS61000- 11K	EVERFINE	G113317CA8 341119	effective
Power frequency	Signal Generator	EMS61000- 8K_500	EVERFINE	G121941CS1 3K1113	effective
magnetic field (PMS)	Power magnetic coil	MFC-4	EVERFINE	G124238BS1 341113	effective
	ANTENNA	HL046	R&S	4040-8708.02- 10067	effective
Electromagne	ANTENNA	STLP9149	Schwarzbeck	/	effective
susceptibility (RS)	Amplifier	CBA 1G-250	TESEQ	T44132	effective
	Amplifier	CBA 3G-050	TESEQ	T43983	effective
(MEPQ	SG	SMB 100A	R&S	105929	effective
Lab)	Power Meter	NRP-Z91	R&S	101612	effective
	Field probe	FL7006	AR	0338716	effective

Auto Test Software Information					
Test Item	Manufacturer	MODEL	Version		
Radiated emission	AUDIX	E3	8.2014-7-10A		
Conducted emission	R&S	EMC32	V8.53		
Conducted immunity	EM TEST	EM TEST	CWS500N		
Current Harmonic	HAEFELY EMC	PHF X	V1.34		
Voltage fluctuation and Flicker	HAEFELY EMC	PHF X	V1.34		



2.4 Test Summary

TEST ITEM	RESULT	NOTE
Conducted disturbance voltage at mains	PASS	
terminals		
Conducted disturbance voltage at	PASS	
telecommunication ports		
Radiated emission	PASS	
Harmonics	PASS	
Flicker	PASS	
ESD	PASS	
EFT	PASS	
Surge	PASS	
Conducted immunity	PASS	
Radiated immunity	PASS	Test by MEPQ Lab
AC Dip, interrupt	PASS	
Power magnetic field	PASS	

Note 1: NA =Not Applicable

Note 2: This report applies to tested sample only. The test results have been compared directly with the limits, and the measurement uncertainty is recorded. This report shall not be reproduced in part without written approval of Hangzhou TDT Technologies Co., Ltd.



Emission Test

3. Conducted disturbance voltage at mains terminals

Test result: PASS

3.1 Limits

3.1.1 Limits for conducted disturbance voltage at the mains ports of class A

Requirements for conducted emissions from the AC mains power ports of Class A equipment

Applicabl	e to			
1. AC mai	ns power ports (3.1.1)			
Table clause	Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class A limits dB(μV)
A9.1	0,15 to 0,5	AMN	Ouesi Bask / 0 kHz	79
ļ	0,5 to 30		Quasi Peak / 9 km2	73
A9.2	0,15 to 0,5			66
ļ	0,5 to 30	AMIN	Average / 9 KHZ	60
	1 and AQ 2 across the opti	ro froquency range		

Apply A9.1 and A9.2 across the entire frequency range.

3.1.2 Limits for conducted disturbance voltage at the mains ports of class B device

Requirements for conducted emissions from the AC mains power ports of Class B equipment

Applicabl	e to			
1. AC mai	ns power ports (3.1.1)			
Table clause	Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class B limits dB(µV)
A10.1	0,15 to 0,5			66 to 56
	0,5 to 5	AMN	Quasi Peak / 9 kHz	56
	5 to 30			60
A10.2	0,15 to 0,5			56 to 46
	0,5 to 5	AMN	Average / 9 kHz	46
	5 to 30			50



3.2 Test setup ⊠ For table top equipment



The 0,8 m distance specified between EUT/AE/PSU and AMN/AAN, is applicable only to the EUT being measured. If the device is AE then it shall be £0,8 m.







3.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were following clause 4 of CISPR 16-1-1 & CISPR 16-1-2.

Detailed test procedure was following clause 6.3 of EN 55032.

EUT arrangement and operation conditions were according to clause 6 of EN 55032. Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9 kHz.



3.4 Test Protocol

Temperature	:	20°C
Relative Humidity	:	49 %RH
Atmospheric Pressure	:	101.1kPa

Mode 1 (GV-ADR4701 + DC adapter) Line+ Neutral

TDT

Hangzhou TDT Technologies Co., Ltd. tel:0571-88317620 fax:0571-88316350

CE Test Report

Common Information

EUT: Power Note:

Environment Conditions: Operator Name: AC 230V 50Hz Level(dBuV)=Reading(dBuV)+Corr. (dB) Margin(dB)=Limit(dBuV)-Level(dBuV) 21degrees Celsius,54%humidity,101KPa TANGSHITAO



Final Result 1

Frequency (MHz)	QuasiPeak (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)	Comment
0.157287	46.4	1000.0	9.000	On	L1	19.9	32.6	79.0	
0.234378	39.4	1000.0	9.000	On	N	19.9	39.6	79.0	
3,279739	30.0	1000.0	9.000	On	N	20.0	43.0	73.0	
5.889111	27.8	1000.0	9.000	On	L1	20.0	45.2	73.0	
16.227652	35.6	1000.0	9.000	On	N	20.3	37.4	73.0	
28.680688	25.8	1000.0	9.000	On	N	20.4	47.2	73.0	

Final Result 2

Frequency (MHz)	CAverage (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)	Comment
0.187359	30.4	1000.0	9.000	On	L1	19.9	35.6	66.0	
1.631379	20.4	1000.0	9.000	On	N	19.9	39.6	60.0	
2.983792	18.6	1000.0	9.000	On	N	20.0	41.4	60.0	÷
11.953740	25.4	1000.0	9.000	On	N	20,2	34.6	60.0	1
17.690662	30.2	1000.0	9.000	On	N	20.4	29.8	60.0	
28.686520	25.6	1000.0	9.000	On	N	20.4	34.4	60.0	e 6

Notes:

1. All possible modes of operation were investigated. Only the worst case emissions measured.



3.5 Measurement Uncertainty

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT.

Measurement uncertainty at mains terminal: \pm 2.66dB.

The measurement uncertainty is given with a confidence of 95%, k=2.

The measurement uncertainty is traceable to internal procedure CXWJ22.



4. Conducted disturbance voltage at telecommunication ports

Test result: PASS

4.1 Limits

4.1.1 Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 to 30MHz for class A equipment

le to								
 wired network ports (3.1.32) optical fibre ports (3.1.25) with metallic shield or tension members antenna ports (3.1.3) 								
Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class A voltage limits dB(µV)	Class A current limits dB(µA)				
0,15 to 0,5	4 A N	Quasi Book / 0 kHz	97 to 87					
0,5 to 30	AAN	Quasi reak / 9 km2	87	n/2				
0,15 to 0,5	4 A N	Average / 0 kHz	84 to 74	n/a				
0,5 to 30	AAN	Average / 9 km2						
0,15 to 0,5	CVP	Quasi Peak / 0 kHz	97 to 87	53 to 43				
0,5 to 30	and current probe		87	43				
0,15 to 0,5	CVP	Average / 0 kHz	84 to 74	40 to 30				
0,5 to 30	and current probe	Average / 9 kHz	74	30				
0,15 to 0,5	Current Brobo	Quasi Book / 0 kHz		53 to 43				
0,5 to 30	to 30		n/a	43				
0,15 to 0,5		in/a	40 to 30					
0,5 to 30	O Average / 9 kHz			30				
	le to network ports (3.1 a ports (3.1.3) Frequency range MHz 0,15 to 0,5 0,5 to 30 0,15 to 0,5 0,5 to 30 0,5 to 30	le to network ports (3.1.32) fibre ports (3.1.25) with metallic shield or to a ports (3.1.3) Frequency range MHz 0,15 to 0,5 0,15 to 0,5 CVP 0,5 to 30 0,15 to 0,5 CUP 0,5 to 30 0,15 to 0,5 CUP 0,15 to 0,5 0,15 to 0,5 0,15 to 0,5 0,15 to 0,15 0,15 to 0,15 0	le to network ports (3.1.32) fibre ports (3.1.25) with metallic shield or tension members a ports (3.1.3) Frequency range MHz Coupling device (see Table A.8) Coupling device (see Table A.8) Detector type / bandwidth 0,15 to 0,5 AAN Quasi Peak / 9 kHz 0,15 to 0,5 CVP and current probe Quasi Peak / 9 kHz 0,15 to 0,5 CVP and current probe Quasi Peak / 9 kHz 0,15 to 0,5 CVP and current probe Quasi Peak / 9 kHz 0,15 to 0,5 CVP Average / 9 kHz 0,15 to 0,5 CVP Quasi Peak / 9 kHz 0,15 to 0,5 CVP Average / 9 kHz 0,15 to 0,5 CUPP Average / 9 kHz 0,15 to 0,5 CUPP	le tonetwork ports (3.1.32) fibre ports (3.1.25) with metallic shield or tension members a ports (3.1.3)Frequency range MHzCoupling device (see Table A.8)Detector type / bandwidthClass A voltage limits dB(μV)0,15 to 0,5 0,5 to 30AANQuasi Peak / 9 kHz97 to 870,5 to 30AANAverage / 9 kHz84 to 740,15 to 0,5 0,5 to 30AANAverage / 9 kHz97 to 870,15 to 0,5 0,5 to 30CVP and current probeQuasi Peak / 9 kHz97 to 870,15 to 0,5 0,5 to 30CVP and current probeAverage / 9 kHz97 to 870,15 to 0,5 0,5 to 30CVP and current probeAverage / 9 kHz97 to 870,15 to 0,5 0,5 to 30CVP and current probeAverage / 9 kHz10/10000000000000000000000000000000000				

Requirements for asymmetric mode conducted emissions from Class A equipment

The choice of coupling device and measurement procedure is defined in Annex C.

AC mains ports that also have the function of a wired network port shall meet the limits given in Table A.9.

The measurement shall cover the entire frequency range.

The application of the voltage and/or current limits is dependent on the measurement procedure used. Refer to Table C.1 for applicability.

Testing is required at only one EUT supply voltage and frequency.

Applicable to ports listed above and intended to connect to cables longer than 3 m.



4.1.2 Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 to 30MHz for class B equipment

Requirements for asymmetric mode conducted emissions from Class B equipment

Applicable to									
 wired r optical broado antenn 	 wired network ports (3.1.32) optical fibre ports (3.1.25) with metallic shield or tension members broadcast receiver tuner ports (3.1.8) antenna ports (3.1.3) 								
Table clause	Frequency range MHz	Coupling device (see Table A.8)	Detector type / bandwidth	Class B voltage limits dB(µV)	Class B current limits dB(µA)				
A12.1	0,15 to 0,5								
	0,5 to 30	AAN	Quasi reak / 9 km2	74	2/2				
	0,15 to 0,5		Average / 0 kHz	74 to 64	11/a				
	0,5 to 30	AAN	Average / 9 kHz	64					
A12.2	0,15 to 0,5	CVP	Quasi Book / 0 kHz	84 to 74	40 to 30				
	0,5 to 30	and current probe	Quasi reak / 9 km2	74	30				
	0,15 to 0,5	CVP	Average / 0 kHz	74 to 64	30 to 20				
	0,5 to 30	and current probe	Average / 9 kHz	64	20				
A12.3	0,15 to 0,5	Current Probo	Quasi Book / 0 kHz		40 to 30				
	0,5 to 30	Current Probe	Quasi reak / 9 km2	- 1-	30				
	0,15 to 0,5	Current Probe		11/d	30 to 20				
	0,5 to 30	Current Probe Average / 9 kHz			20				

The choice of coupling device and measurement procedure is defined in Annex C.

Screened ports including TV broadcast receiver tuner ports are measured with a common-mode impedance of 150 Ω . This is typically accomplished with the screen terminated by 150 Ω to earth.

AC mains ports that also have the function of a wired network port shall meet the limits given in Table A.10.

The measurement shall cover the entire frequency range.

The application of the voltage and/or current limits is dependent on the measurement procedure used. Refer to Table C.1 for applicability.

Measurement is required at only one EUT supply voltage and frequency.

Applicable to ports listed above and intended to connect to cables longer than 3 m.



4.2 Test setup





The 0.8 m distance specified between EUT/AE/PSU and AMN/AAN, is applicable only to the EUT being measured. If the device is AE then it shall be ϵ 0.8 m.



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4.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were following clause CISPR 16-1-1 & CISPR 16-1-2.

Detailed test procedure was following clause 6.3 of EN 55032.

EUT arrangement and operation conditions were according to clause 6 of EN 55032. Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9 kHz.



4.4 Test Protocol

TDT

:	21 °C
:	49%RH
:	101.1kPa
	: : :

Mode 1 (GV-ADR4701 + DC adapter) LAN PORT

Hangzhou TDT Technologies Co., Ltd. tel:0571-88317620 fax:0571-88316350

CE Test Report

Common Information EUT: Power Note:

AC 230V 50Hz Level=Reading+Corr. 21°,54%RH,101KPa QHH Environment Conditions: Operator Name:

Margin=Limit-Level



Final Result 1

Frequency (MHz)	QuasiPeak (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
16.166659	61.6	1000.0	9.000		10.1
16,227849	62.7	1000.0	9.000		10.1
17.694259	62.6	1000.0	9.000		10.2
18,242036	63,4	1000,0	9.000		10.2
18.304625	62.2	1000.0	9.000		10.2
18.364740	61,5	1000.0	9.000		10.2

(continuation of the "Final Result 1" table from column 6 ...)

Frequency (MHz)	Marg in (dB)	Limit (dBu V)
16.166659	25.4	87.0
16.227849	24.3	87.0
17.694259	24.4	87.0
18.242036	23.6	87.0
18.304625	24.8	87.0
18.364740	25.5	87.0



Final Result 2							
Frequency (MHz)	CAverage (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)		
16.166718	57,5	1000.0	9.000		10.1		
16.227314	58.7	1000.0	9.000		10.1		
17.692618	58.3	1000.0	9.000		10.2		
18.243368	59.1	1000.0	9.000		10.2		
18.303881	57.8	1000.0	9.000		10.2		
18.365795	56.8	1000.0	9,000		10.2		

(continuation of the "Final Result 2" table from column 6 ...)

Frequency (MHz)	Marg in (dB)	Limit (dBu V)	
16.166718	16.5	74.0	
16.227314	15.3	74.0	
17.692618	15.7	74.0	
18.243368	14.9	74.0	
18.303881	16.2	74.0	
18.365795	17.2	74.0	

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Mode 2 (GV-ADR4701 + POE) LAN PORT

TDT

Hangzhou TDT Technologies Co., Ltd. tel:0571-88317620 fax:0571-88316350

CE Test Report

Common Information

EUT: Power Note: Environment Conditions: Operator Name:

AC 230V 50Hz Level=Reading+Corr. Margin=Limit-Level 21°,54%RH,101KPa QHH



Final Result 1

Frequency (MHz)	QuasiPeak (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)
0.469253	64.5	1000.0	9.000		10.1	23.1	87.5
0.733971	73.7	1000.0	9.000		10.0	13.3	87.0
1.279314	73.0	1000.0	9.000		9.9	14.0	87.0
1.549786	66.1	1000.0	9.000		10.0	20.9	87.0
2.201642	72.4	1000.0	9.000	- E	10.1	14.6	87.0
3.399864	62.1	1000.0	9.000		10.1	24.9	87.0

Final Result 2

Frequency (MHz)	CAverage (dBuV)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBuV)
0.451141	66.0	1000.0	9.000		10.1	8.9	74.9
0.746832	53.0	1000.0	9.000		10.0	21.0	74.0
1.171944	47.4	1000.0	9.000		9.9	26.6	74.0
1.546288	46.3	1000.0	9.000		10.0	27.7	74.0
2.205672	69.9	1000.0	9.000		10.1	4.1	74.0
3.549273	65.1	1000.0	9.000		10.1	8.9	74.0

Notes:

1. All possible modes of operation were investigated. Only the worst case emissions measured.



4.5 Measurement Uncertainty

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT.

Measurement uncertainty at telecom terminal: ± 3.82 dB.

The measurement uncertainty is given with a confidence of 95%, k=2.

The measurement uncertainty is traceable to internal procedure CXWJ22.



5. Radiated emission

Test result: PASS

5.1 Radiated emission limits

5.1.1 Limits for radiated disturbance of class A device

Table	Frequency		Measurement		Class A limits
clause	range MHz	Facility (see Table A.1)	Distance m	Detector type / bandwidth	dB(µV/m)
A2.1	30 to 230	OATE/EAC	10		40
	230 to 1 000	UATS/SAC	10	Quasi Peak /	47
A2.2	30 to 230	0478/840 2		120 kHz	50
	230 to 1 000	UATSISAC	3	Γ	57
A2.3	30 to 230	EAD	4 b		42 to 35
	230 to 1 000	FAR	קי	Quasi Peak /	42
A2.4	30 to 230	EAD.	2	120 kHz	52 to 45
	230 to 1 000	FAR	3	Γ	52
Apply only	A2.1 or A2.2 or A2.	3 or A2.4 across the	entire frequency r	ange.	

Requirements for radiated emissions at frequencies up to 1 GHz for class A equipment

Requirements for radiated emissions at frequencies above 1 GHz for class A equipment

Table	Frequency		Measurement	Class A limits	
clause	range MHz	Facility (see Table A.1)	Distance m	Detector type / bandwidth	dB(µV/m)
A3.1	1 000 to 3 000			Average /	56
	3 000 to 6 000	FROATS	2	1 MHz	60
A3.2	1 000 to 3 000	FSUATS	3	Peak /	76
	3 000 to 6 000			1 MHz	80

Apply A3.1 and A3.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.



5.1.2 Limits for radiated disturbance of class B device

Requirements for radiated emissions at frequencies up to 1 GHz for class B equipment

Table	Frequency		Measurement		Class B limits
clause	MHz	Facility (see Table A.1)	Distance m	Detector type / bandwidth	dB(μ∨/m)
A4.1	30 to 230	OATS/SAC	10		30
	230 to 1 000	UATS/SAC	10	Quasi Peak /	37
A4.2	30 to 230	OATE/EAC	2	120 kHz	40
	230 to 1 000	UATS/SAC	3		47
A4.3	30 to 230	EAD	10		32 to 25
	230 to 1 000	FAR	10	Quasi Peak /	32
A4.4	30 to 230	EAD	3	120 kHz	42 to 35
	230 to 1 000	LAN	3		42

Apply only table clause A4.1 or A4.2 or A4.3 or A4.4 across the entire frequency range.

These requirements are not applicable to the local oscillator and harmonics frequencies of equipment covered by Table A.6.

Requirements for radiated emissions at frequencies above 1 GHz for class B equipment

Table	Frequency		Measurement		Class B limits
clause	range MHz	Facility (see Table A.1)	Distance m	Detector type/ bandwidth	dB(µ∨/m)
A5.1	1 000 to 3 000			Average/	50
	3 000 to 6 000	FROATS	2	1 MHz	54
A5.2	1 000 to 3 000	FSUATS	3	Peak/	70
	3 000 to 6 000			1 MHz	74

Apply A5.1 and A5.2 across the frequency range from 1 000 MHz to the highest required frequency of measurement derived from Table 1.



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5.3 Test Setup and Test Procedure

The measurement was performed in a semi-anechoic chamber below 1GHz while performed in a full-anechoic chamber above 1GHz.

The distance from EUT to receiving antenna is 3 meter for 30MHz - 6000MHz. Measurement was performed according to clause 6 of EN 55032.

The bandwidth setting on Test Receiver ESR7 was 120 kHz in frequency band 30 - 1000MHz

The bandwidth setting on FSV40 was 1 MHz in frequency band 1000 – 6000MHz The frequency range from 30MHz to 6000MHz was checked.

For the frequency between 30MHz to 1000MHz, an Bi-conical and log-periodic Antenna was used.

For the frequency between 1000MHz to 6000MHz, a horn antenna was used.



5.4 Test Protocol

Temperature	:	24 °C
Relative Humidity	:	52 %RH
Atmospheric Pressure	:	101.5kPa

Mode 1 (GV-ADR4701 + DC adapter) Horizontal (30M-1GHz)



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth	Remark	
1	104.903	11.88	21.63	33.51	50	16.49	QP	200	159		1
2	151.597	10.31	24.78	35.09	50	14.91	QP	200	332		- 8
3	293.084	14.56	20.34	34.9	57	22.1	QP	100	295		
4	449.556	18.17	23.68	41.85	57	15.15	QP	100	148		1
5	549.019	19.57	20.36	39.93	57	17.07	QP	200	274		1
6	890,728	24.59	16.67	41.26	57	15.74	QP	100	2		



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (v.)	Remark	
1	50.409	12.08	30.75	42.83	50	7.17		100	156		
2	293.084	14.56	21.28	35.84	57	21.16	QP	200	207		1
3	449.556	18.17	23.54	41.71	57	15.29	QP	100	156		
4	549.019	19.57	27.07	46.64	57	10.36	QP	100	180		
5	649.66	21.6	22.33	43.93	57	13.07	QP	100	152		
6	965.542	25.44	18.88	44.32	57	12.68	QP	100	54		_



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth	Remark
1	1158.266	-14.56	52.81	38.25	56	17.75	Average	100	198	
2	1158.266	-14.56	59.81	45.25	76	30.75	Peak	100	198	
3	1996.946	-10.2	46.17	35,97	56	20.03	Average	100	122	
4	1996.946	-10.2	53.17	42.97	76	33.03	Peak	100	122	
5	2594.039	-8.81	37.86	29.05	56	26.95	Average	100	234	
6	2594.039	-8.81	52.86	44.05	76	31.95	Peak	100	234	
7	2972.46	-8.04	35.3	27.26	56	28.74	Average	100	225	
8	2972.46	-8.04	49,3	41.26	76	34.74	Peak	100	225	
9	3268.571	-6.47	35.68	29.21	60	30.79	Average	100	327	
10	3268.571	-6.47	47.68	41.21	80	38.79	Peak	100	327	
11	4997.811	-2.07	36.22	34,15	60	25.85	Average	100	144	
12	4997.811	-2.07	46.22	44.15	80	35.85	Peak	100	144	



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (,)	Remark
1	1038.344	-15.11	57.09	41.98	56	14.02	Average	100	359	
2	1038.344	-15.11	64.09	48.98	76	27.02	Peak	100	359	
3	1501.898	-12.74	46.65	33.91	56	22.09	Average	100	360	
4	1501.898	-12.74	53.65	40.91	76	35.09	Peak	100	360	
5	1832.378	-11.12	46,36	35.24	56	20.76	Average	100	302	
6	1832.378	-11.12	55.36	44.24	76	31.76	Peak	100	302	
7	2397.385	-9.17	47.35	38.18	56	17.82	Average	100	207	
8	2397.385	-9.17	56.35	47.18	76	28.82	Peak	100	207	
9	3568.514	-4.89	39.07	34,18	60	25.82	Average	100	352	-
10	3568.514	-4.89	50.07	45.18	80	34.82	Peak	100	352	
11	3895,981	-4.52	42.66	38.14	60	21.86	Average	100	217	
12	3895.981	-4.52	51,66	47.14	80	32.86	Peak	100	217	



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (+)	Remark
1	36.895	18.09	18.88	36.97	50	13.03	QP	100	146	
2	98.487	10.92	20.73	31.65	50	18.35	QP	200	149	
3	160.909	9.64	22.46	32.1	50	17.9	QP	200	153	
4	293.084	14.56	21.3	35.86	57	21.14	QP	100	313	
5	449.556	18.17	20.61	38.78	57	18.22	QP	100	150	
6	549.019	19.57	20.84	40.41	57	16.59	QP	100	144	



No.	Frequency (MHz)	Factor (dB/m)	Reading (dBuV)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (*)	Remark
1	36.127	18.79	29.5	48.29	50	1.71	QP	100	140	
2	90.22	9.45	26.62	36.07	50	13.93	QP	100	296	
3	151.597	10.31	22.55	32.86	50	17.14	QP	100	99	
4	449.556	18.17	27.93	46.1	57	10.9	QP	100	146	
5	549.019	19.57	25.28	44.85	57	12.15	QP	100	105	
6	965.542	25.44	13.85	39.29	57	17.71	QP	100	92	





5.5 Measurement uncertainty

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT.

Measurement uncertainty of semi-anechoic chamber radiated emission is: \pm 6.28dB. (without tilting)

Measurement uncertainty of fully anechoic chamber radiated emission is: \pm 5.42dB. The measurement uncertainty is given with a confidence of 95%, k=2.

The measurement uncertainty is traceable to internal procedure CXWJ22.

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6. Harmonics

Test result: PASS

6.1 Block Diagram of Test Setup



6.2 Test Setup and Test Procedure

Harmonics of the fundamental current were measured up to 40 order harmonics using a digital power meter with an analogue output and frequency analyser which was integrated in the harmonic & flicker test system. The measurements were carried out under steady conditions.

This product is not defined as lighting equipment, and has rated power less than 75W, therefore, no limit apply according to EN 61000-3-2



6.3 Test Protocol

Temperature	:	24 °C
Relative Humidity	:	55 %RH
Atmospheric Pressure	:	100.5kPa

GV-ADR4701

Harmonics testing according EN61000-3-2

Measuring protocol printed at 06. December 2016 10:35:18 Measuring file:g:\PHF\logging.phf is dated 06. December 2016 10:34:28

Name	Department	Firma	Device	Туре	Manufacturer	Serial N
CNF	EMC Lab	TDT	IPC			NA

An example

PHF Version 1.34 was used. Standard: EN61000-4-7 Limits: EN61000-3-2:2014.

The smoothing filter was switched off. Grouping off.

Measuring time was : 00:30:00

Class A was chosen

Description

Table 1

Table 2

Phase	1
Measuring instrument	PHF
Serial number	08580511
Software version	3.131
Voltage range	250.0 V
Current range	0.6 A
Voltage scale	1.0
Current scale	1.0

Test results

Phase	1
Voltage harmonics check	ok
Voltage magnitude check	ok
Frequency check	ok
Crest factor check	not tested
Phase angle check	not tested
Current harmonics 100% check	ok
Current harmonics 150/200% check	ok
Fluctuating harmonics check	ok

Values measured at 00:00:00 before end of measurement (informative only)

		Table o
Phase	1	
Utrms, V	230.8907	
Itrms, A	0.0585	
S, VA	13.5170	
P, W	4.9941	
Q, VAr	12.5606	
PF	0.3695	
f, Hz	50.0016	

Detailed evaluation results (informative only)

		fluct.,		I/lim,	Frame	Umax, V
n	laver, A	%	Imax, A	%		
0	0.008		0.009			0.40
1	0.032		0.033	0.0	0	230.90
2	0.003		0.003	0.0	0	0.04
3	0.020		0.021	0.9	8	0.15
4	0.003		0.003	0.0	0	0.03
5	0.019		0.020	1.7	8	0.02
6	0.003		0.003	0.0	0	0.01
7	0.018		0.019	2.5	8	0.01
8	0.002		0.003	0.0	0	0.01
9	0.017		0.018	4.4	8	0.01
10	0.002		0.002	0.0	0	0.01
11	0.016		0.016	4.9	8	0.01
12	0.002		0.002	0.0	0	0.01
13	0.014		0.014	6.9	8	0.01
14	0.002		0.002	0.0	0	0.01
15	0.012		0.013	8.4	6	0.01
16	0.001		0.002	0.0	0	0.00
17	0.011		0.011	8.2	6	0.01
18	0.001		0.001	0.0	0	0.01
19	0.009		0.009	7.6	6	0.01
20	0.001		0.001	0.0	0	0.00
21	0.007		0.007	6.7	5270	0.01
22	0.001		0.001	0.0	0	0.00
23	0.005		0.006	5.7	5270	0.01
24	0.001		0.001	0.0	0	0.00
25	0.004		0.004	0.0	0	0.01
26	0.001		0.001	0.0	0	0.00
27	0.003		0.003	0.0	0	0.00
28	0.001		0.001	0.0	0	0.00
29	0.002		0.002	0.0	0	0.00
30	0.001		0.001	0.0	0	0.00
31	0.001		0.001	0.0	0	0.00
32	0.001		0.001	0.0	0	0.00
33	0.001		0.001	0.0	0	0.00
34	0.001		0.001	0.0	0	0.00
35	0.001		0.001	0.0	0	0.00
36	0.001		0.001	0.0	0	0.00
37	0.001		0.001	0.0	0	0.00
38	0.001		0.001	0.0	0	0.00
39	0.002		0.002	0.0	0	0.01
40	0.000		0.001	0.0	0	0.00

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6.4 Measurement Uncertainty

The measurement uncertainty describes the overall uncertainty of the given measured value during the operation of the EUT.

Measurement uncertainty of harmonic test is: Iave=0.474%, Imax=1.16%.

The measurement uncertainty is traceable to internal procedure CXWJ22.



7. Voltage Fluctuations-Flicker

Test result: PASS

7.1 Block Diagram of Test Setup



7.2 Test Setup and Test Procedure

7.2.1 Definition

Flicker:	impression of unsteadiness of visual sensation induced by a lighting stimulus whose luminance or spectral distribution fluctuates with time.
Pst:	Short-term flicker indicator The flicker severity evaluated over a short period (in minutes); Pst=1 is the conventional threshold of irritability
Plt:	long-term flicker indicator; the flicker severity evaluated over a long period (a few hours). Using successive Pst values.
dc:	the relative steady-state voltage change
dmax:	the maximum relative voltage change
d(t):	the value during a voltage change

7.2.2 Test condition

The EUT was set to produce the most unfavorable sequence of voltage changes.



7.3 Test Protocol

The tested object operated under the operating condition specified in EN61000-3-3. The following limits apply

- -- "Plt" shall not exceed 0.65.
- -- "Pst" shall not exceed 1.0.
- -- "dc" shall not exceed 3.3%.
- -- "dmax" shall not exceed 4/6/7%*
- -- d(t) shall not exceed 3.3% for more than 500ms.

Notes: * means for 4% limit, without additional conditions

6% limit, switched manually or automatically more than twice per day 7% limit, switched automatically for no more than twice per day or attended while in use.

Temperature	:	24 °C
Relative Humidity	:	57 %RH
Atmospheric Pressure	:	100.5kPa

GV-ADR4701

Harmonics testing according EN61000-3-2

Measuring protocol printed at 06. December 2016 10:35:18 Measuring file:g:\PHF\logging.phf is dated 06. December 2016 10:34:28

Name	Department	Firma	Device	Туре	Manufacturer	Serial N
CNF	EMC Lab	TDT	IPC			NA

An example

PHF Version 1.34 was used. Standard: EN61000-4-7 Limits: EN61000-3-2:2014. The smoothing filter was switched off. Grouping off. Measuring time was : 00:30:00 Class A was chosen

Description

Table 1

Table 2

Phase	1	
Measuring instrument	PHF	
Serial number	08580511	
Software version	3.131	
Voltage range	250.0 V	
Current range	0.6 A	
Voltage scale	1.0	
Current scale	1.0	

Test results

Phase	1
Voltage harmonics check	ok
Voltage magnitude check	ok
Frequency check	ok
Crest factor check	not tested
Phase angle check	not tested
Current harmonics 100% check	ok
Current harmonics 150/200% check	ok
Fluctuating harmonics check	ok

Values measured at 00:00:00 before end of measurement (informative only)

Phase	1
Utrms, V	230.8907
Itrms, A	0.0585
S, VA	13.5170
P, W	4.9941
Q, VAr	12.5606
PF	0.3695
f, Hz	50.0016

Detailed evaluation results (informative only)

			Table 4			
n	laver A	fluct., %	Imax A	l/lim, %	Frame	Umax, V
0	0.008	70	0.009	/0		0.40
1	0.000		0.003		0	220.00
2	0.032		0.003	0.0	0	230.90
2	0.003		0.003	0.0	•	0.04
3	0.020		0.021	0.9	0	0.15
4	0.003		0.003	0.0	0	0.03
5	0.019		0.020	1.7	0	0.02
7	0.003		0.003	0.0	0	0.01
/ 0	0.010		0.019	2.5	0	0.01
8	0.002		0.003	0.0	0	0.01
9	0.017		0.018	4.4	8	0.01
10	0.002		0.002	0.0	0	0.01
11	0.016		0.016	4.9	8	0.01
12	0.002		0.002	0.0	0	0.01
13	0.014		0.014	6.9	8	0.01
14	0.002		0.002	0.0	0	0.01
15	0.012		0.013	8.4	6	0.01
16	0.001		0.002	0.0	0	0.00
17	0.011		0.011	8.2	6	0.01
18	0.001		0.001	0.0	0	0.01
19	0.009		0.009	7.6	6	0.01
20	0.001		0.001	0.0	0	0.00
21	0.007		0.007	6.7	5270	0.01
22	0.001		0.001	0.0	0	0.00
23	0.005		0.006	5.7	5270	0.01
24	0.001		0.001	0.0	0	0.00
25	0.004		0.004	0.0	0	0.01
26	0.001		0.001	0.0	0	0.00
27	0.003		0.003	0.0	0	0.00
28	0.001		0.001	0.0	0	0.00
29	0.002		0.002	0.0	0	0.00
30	0.001		0.001	0.0	0	0.00
31	0.001		0.001	0.0	0	0.00
32	0.001		0.001	0.0	0	0.00
33	0.001		0.001	0.0	0	0.00
34	0.001		0.001	0.0	0	0.00
35	0.001		0.001	0.0	0	0.00
36	0.001		0.001	0.0	0	0.00
37	0.001		0.001	0.0	0	0.00
38	0.001		0.001	0.0	0	0.00
39	0.002		0.002	0.0	0	0.01
40	0.000		0.001	0.0	0	0.00

The EUT has no means to generate the flicker exceed the specific limit, so it is deemed to fulfill with the requirement without testing.



Immunity Test

Performance criteria

The performance criteria are based on the general criteria of the standard and derived from the product specification

Criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Basic EMC standard for immunity test

IEC 61000-4-2: 2008: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 2: electrostatic discharge immunity test

IEC 61000-4-3: 2010: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 3: radiated, radio frequency, electromagnetic field immunity test

IEC61000-4-4: 2012: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 4: electric fast transient/burst immunity test

IEC 61000-4-5: 2014: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 5: surge immunity test



IEC 61000-4-6: 2013: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 6: immunity to conducted disturbance, induced by radio frequency field

IEC 61000-4-8:2009: Electromagnetic compatibility (EMC) — Part 4: Testing and measurement techniques — Section 8: Power frequency magnetic field immunity test.

IEC61000-4-11: 2004: Electromagnetic Compatibility (EMC) – Part 4: testing and measurement techniques – section 11: voltage dips, short interruption and voltage variations immunity test



8. Electrostatic Discharge (ESD)

Test result PASS

8.1 Severity Level and Performance Criterion

8.1.1 Test level

1a – Contac	ct discharge	1b – Air discharge		
Level	Test voltage kV	Level	Test voltage kV	
1	2	1	2	
2	4	2	4	
3	6	3	8	
4	8	4	15	
Х	Special	X	Special	

Notes: 1."X" is an open level. The level has to be specified in the dedicated equipment specification. If higher voltages than those shown are specified, special test equipment may be needed.

2. The gray rows were the selected test level.

8.1.2 Performance Criterion

Performance criterion: B



8.2 Block Diagram of Test Setup





Note: VCP means <u>Vertical Coupling Plane</u> GRP means <u>Ground Reference Plane</u> Wooden support is a 0.1m height rack



8.3 Test Setup and Test Procedure

Measurement was performed in shielded room. Measurement and setting of EUT was applied according to IEC61000-4-2 clause 7.1.

8.4 Test Protocol

Temperature	:	24 °C
Relative Humidity	:	54 %RH
Atmospheric Pressure	:	99.5kPa
Direct discharges were a	pplied a	at the following selected points:

Dischar (Circumfe	Contact discharge (6kV)		Air discharge (2kV, 4 kV, 8kV)		
		(+)	(-)	(+)	(-)
	Cover	NA	NA	PASS	PASS
GV-ADR4701	LAN Port	NA	NA	PASS	PASS
	Screw	NA	NA	PASS	PASS
	DC PORT	NA	NA	PASS	PASS

Indirect contact discharges were applied to the VCP and the HCP at the following selected points:

 \boxtimes For table top equipment

Point	Description	Point	Result
HCP f	0,1m from the front of the EUT	Edge of centre, corner on HCP	PASS
HCP b	0,1m from the back of the EUT	Edge of centre, corner on HCP	PASS
HCP r	0,1m from the right side of the EUT	Edge of centre, corner on HCP	PASS
HCP1	0,1m from the left side of the EUT	Edge of centre, corner on HCP	PASS
VCP f	0,1m from the front of the EUT	Edge of centre, corner on VCP	PASS
VCP b	0,1m from the back of the EUT	Edge of centre, corner on VCP	PASS
VCP r	0,1m from the right of the EUT	Edge of centre, corner on VCP	PASS
VCP1	0,1m from the left of the EUT	Edge of centre, corner on VCP	PASS

For floor standing equipment

Point	Description	Point	Result
VCP f	0,1m from the front of the EUT	Edge of centre, corner on VCP	-
VCP b	0,1m from the back of the EUT	Edge of centre, corner on VCP	-
VCP r	0,1m from the right of the EUT	Edge of centre, corner on VCP	_
VCP1	0,1m from the left of the EUT	Edge of centre, corner on VCP	-

Observation: No any change after the test.

Conclusion: The EUT complied with performance criteria B of this test.

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8.5 ESD test points

Red: contact discharge **Green**: air discharge

GV-ADR4701:





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8.6 Additions, Deviations and Exclusions from Standards

None

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9. Electromagnetic field susceptibility

Test result PASS

9.1 Severity Level and Performance Criterion

9.1.1 Test level

Level	Test field strength V/m
1	1
2	3
3	10
X	Special

Note: 1. X is an open test level. This level may be given in the product specification. 2. The gray row is the selected test level.

9.1.2 Performance Criterion Performance criterion: A

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9.2 Block diagram of test setup



9.3 Test Setup and Test Procedure

Measurement was performed in full-anechoic chamber. Measurement and setting of EUT was applied according to IEC61000-4-3 clause 7.

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9.4 Test Protocol

Temperature	:	21 °C
Relative Humidity	:	42 %RH
Atmospheric Pressure	:	100.3kPa

Test no.:	Frequency (MHz)	Polarization	Test level V/m	Sides tested	Result	Comment
1	80-1000	H & V	3	Front, Back, Left, Right	PASS	Test by MEPQ Lab

Observation: No any change during the test.

Conclusion: The EUT complied with performance criteria A of this test.

9.5 Additions, deviations and exclusions from standards

None



10. Electric Fast Transient/Burst Immunity Test

Test result PASS

10.1 Severity Level and Performance Criterion

10.1.1 Test level

Open circuit output test voltage $(+/-10\%)$ and repetition rate of the impulses $(+/-20\%)$									
	On power su	pply ports PE	On I/O (inpu	it & output)					
Level			signal, data and c	control ports					
	Voltage peak	Repetition rate	Voltage peak	Repetition rate					
	kV	kHz	kV	kHz					
1	0.5	5	0.25	5					
2	1	5	0.5	5					
3	2	5	1	5					
4	4	2.5	2	5					
X	Special	Special	Special	Special					

Notes : 1. "X" is a an open level. The level has to be specified in the dedicated equipment specification.

2. The gray rows were the selected test level.

10.1.2 Performance Criterion

Performance criterion **B**



10.2 Block Diagram of Test Setup

10.2.1 Block Diagram for input a.c./d.c. power line

For table-top equipment







10.3 Test Setup and Test Procedure

Measurement was performed in shielded room. Measurement and setting of EUT was applied according to IEC61000-4-4 clause 7.2.

10.4 Test Protocol

Temperature	:	23°C
Relative Humidity	:	44 %RH
Atmospheric Pressure	:	102.5kPa

	Port		Test Level [kV]	Result
DC port	Power	L-PE	±1.0; ±2.0	PASS
DC port	line	N-PE	±1.0; ±2.0	PASS
Signal port	Signa	l cable	±0.5; ±1.0	PASS
Notes: "NA" means not applicable.				

Observation: No any change after the test.

Conclusion: The EUT complied with performance criteria B of this test.

10.5 Additions, Deviations and Exclusions from Standards

None



11. Surge Immunity Test

Test result PASS

11.1 Severity Level and Performance Criterion

11.1.1 Test level

Level	Open-sircuit test voltage +/-10%
	kV
1	0.5
2	1.0
3	2.0
4	4.0
X*	Special

Notes: 1."X" is an open class. This level can be specified in the product Specification 2. The gray rows are the selected level. Class 2 is applied to Phase to Phase (L-N) Class 3 is applied to Phase to PE (L-PE),(N-PE)

11.1.2 Performance Criterion Performance criterion **B**



11.2 Block Diagram of Test Setup

11.2.1 Block Diagram for surge



11.3 Test Setup and Test Procedure

Measurement was performed in shielded room. Measurement and setting of EUT was applied according to IEC61000-4-5 clause 7.

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11.4 Test Protocol

Temperature	:	23 °C
Relative Humidity	:	44 %RH
Atmospheric Pressure	:	102.5kPa

Configurator	Port		Matching Resister Ω	Wave µs	Level kV	Judge Limit	Result
	DC12 V	Line to earth	12	1.2/50	±1,2,4KV	В	PASS
GV-ADR4701	LAN	Signal to earth	40	10/700	±0.5,1,2KV	В	PASS

Note: Number of tests: at least five positive and five negative at the selected points; Repetition rate: maximum 1/min

Observation: No any change after the test.

Conclusion: The EUT complied with performance criteria B of this test.

11.5 Additions, Deviations and Exclusions from Standards

None



12. Immunity to Conducted Disturbances, Induced by Radio-frequency Fields

Test result PASS

12.1 Severity Level and Performance Criterion

12.1.1 Test level

Frequency range 150 kHz – 80MHz					
Level	Voltage le	vel (e.m.f.)			
	U0 [dB(uV)] U0 (V)				
1	120	1			
2	130	3			
3	140	10			
Х	X Special Special				

Notes: 1. "X" is an open level

2. The gray row is the selected test level.

12.1.2 Performance Criterion Performance criterion A



12.2 Block Diagram of Test Setup

12.2.1 Block Diagram for a.c./d.c input power line

Block Diagram for d.c input power line



- 12.2.2 Block Diagram for output d.c. power line or signal/control lines
- Unshielded line





Ttermination 50ΩT2power attenuator (6dB)CDNcoupling and decoupling networkInjection clampcurrent clamp or EM clamp

12.3 Test Setup and Test Procedure

Measurement was performed in shielded room. Measurement and setting of EUT was applied according to IEC61000-4-6 clause 7.



12.4 Test Protocol

Temperature	:	23 °C
Relative Humidity	:	44%RH
Atmospheric Pressure	:	101.5kPa

Test	Frequency	Level	Amplitude	Injected point	Result
No.	(MHz)	V (e.m.f.)	modulation		
1	0.15~80	3	1kHz 80% AM	DC port	Pass
2	0.15~80	3	1kHz 80% AM	LAN port	Pass

Observation: All the functions were operated as normal during and after test.

Conclusion: The EUT met the requirements of Performance A

12.5 Additions, Deviations and Exclusions from Standards

None



13. Voltage Dips and voltage Interruptions

Test result PASS

13.1 Severity Level and Performance Criterion

13.1.1 Test level and performance criterion

Test level	Voltage level	Duration	Performance
	in % of rated Ut		criterion
Reduction (%)		(in period)	
>95	<5	0.5	В
30	70	25	С
>95	<5	250	С

13.2 Block diagram of test setup



13.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to IEC61000-4-11 clause 7. The test method and equipment was specified by IEC61000-4-11 with additions and modifications by clause 4.2.6 and 6 of EN 55024.



13.4 Test Protocol

Temperature	:	25 °C
Relative Humidity	:	42 %RH
Atmospheric Pressure	:	102.5kPa

Rated voltage [V]	Item	Test level of reduction [%]	Duration (period)	Result
100 Valtara d'u		>95	0.5	PASS
(Lower voltage)	vonage dip	30	25	PASS
	Short interruption	>95	250	PASS
240 (Upper voltage)	Voltage dip	>95	0.5	PASS
		30	25	PASS
	Short interruption	>95	250	PASS

Observation: All the functions were operated as normal during and after test.

Conclusion: The EUT met the requirements of Performance B or C.

13.5 Additions, deviations and exclusions from standards

None



14. Power Frequency Magnetic field

Test result: PASS

14.1 Severity Level and Performance Criterion

14.1 Test level

Level	Magnetic field strength A/m
1	1
2	3
3	10
4	30
5	100
X	Special

Note: 1. X is an open test level; this level may be given in the product specification. 2. The gray row is the selected test level.

14.1.2 Performance Criterion Performance criterion A

14.2 Diagram of Test Setup



14.3 Test Setup and Test Procedure

Measurement was performed in shielded room.

Measurement and setting of EUT was applied according to clause 7 and 8 of IEC61000-4-8.

The test method and equipment was specified by IEC61000-4-8 with additions and modifications by clause 4.2.6 and 6 of EN 55024.



14.4 Test Protocol

Temperature	:	24 °C
Relative Humidity	:	54 %RH
Atmospheric Pressure	:	100.5kPa

Test No.	Level	Axis	Duration	Result	Comment
	A/m		S		
1	1	Х	900	PASS	NA
2	1	Y	900	PASS	NA
3	1	Z	900	PASS	NA

Observation: All the functions were operated as normal during and after test.

Conclusion: The EUT met the requirements of Performance A

14.5 Additions, Deviations and Exclusions from Standards

None



Appendix I: Photograph of equipment under test



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Appendix II: Model Names

Internal Models	Certificate Models	Differences	Note
GV-ADR4701	GV-ADR4701	NA	Original Report: RZBG(E) 20171225013-C This Report: RZBG(E)20180419001-C

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Appendix III: Photograph of test arrangement



Conducted emission

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Harmonics& Flicker



Electrostatic Discharge



Electromagnetic field susceptibility



Electric Fast Transient/Burst Immunity Test

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Surge Immunity Test



Immunity to Conducted Disturbances, Induced by Radio-frequency Fields



Voltage Dips and voltage Interruptions



Power Frequency Magnetic field

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